

**Notice of References Cited**

Application/Control No.

10/527,531

Applicant(s)/Patent Under  
Reexamination  
OGYU ET AL.

Examiner

Diana J. Liao

Art Unit

4116

Page 1 of 1

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*	B	US-6,827,754	12-2004	Suwabe et al.	55/523
*	C	US-7,087,286	08-2006	Hijikata, Toshihiko	428/116
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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